

100V N-Channel Power SpeedFET

General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. It is suitable for automotive application.

Features

- AEC-Q101 Qualified
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

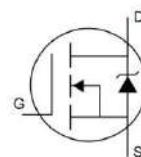
Application

- BLDC Motor driver
- DC-DC
- Load Switch

Ordering Information:

Part NO.	KL420N10-V
Marking	420N10

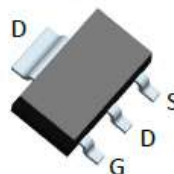
Product Summary



$$V_{DS} = 100V$$

$$R_{DS(ON)} = 50m\Omega$$

$$I_D = 7.5A$$



SOT-223



Absolute Maximum Ratings ($T_C=25^\circ C$)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		100	V
Gate-Source Voltage ^①	V_{GS}		± 20	V
Continuous Drain Current	I_D	$T_C=25^\circ C$	7.5	A
	I_D	$T_C=75^\circ C$	6	A
	I_D	$T_C=100^\circ C$	5	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu s$; $T_{mb} = 25^\circ C$;	22.5	A
Total Power Dissipation	P_D	$T_C=25^\circ C$	8	W
Total Power Dissipation	P_D	$T_A=25^\circ C$	1.0	W
Operating Junction Temperature	T_J		-55 to +150	$^\circ C$
Storage Temperature	T_{STG}		-55 to +150	$^\circ C$
Single Pulse Avalanche Energy	E_{AS}	$L=0.1mH$, $V_{GS}=10V$, $R_g=25\Omega$,	10	mJ
		$L=0.5mH$, $V_{GS}=10V$, $R_g=25\Omega$,	21	mJ
ESD Level (HBM)	CLASS 1B			

●Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}		-	15	°C/W
Thermal resistance, junction-ambient ^②	R_{thJA}		-	120	°C/W
Soldering temperature (total time<10s)	T_{sold}		-	260	°C

●Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	100			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1.3	1.8	2.5	V
Drain-Source Leakage Current	I_{DSS}	$V_{GS}=0V, V_{DS}=100V$			1.0	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$			100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=10A$		50	65	m Ω
		$V_{GS}=4.5V, I_D=6A$		64	83	m Ω
Forward Transconductance	g_{FS}	$V_{DS}=5V, I_{SD}=10A$		4		S
Diode Forward Voltage	V_{FSD}	$V_{GS}=0V, I_{SD}=10A$			1.3	V

●Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$f=1MHz, V_{DS}=25V$	-	275	-	pF
Output capacitance	C_{oss}		-	146	-	
Reverse transfer capacitance	C_{rss}		-	3.7	-	
Gate Resistance	R_g	$f=1MHz$	-	1.3		Ω
Total gate charge	Q_g	$V_{DD}=15V, I_D=20A, V_{GS}=10V$	-	7	-	nC
	$Q_g(4.5V)$		-	4	-	
Gate - Source charge	Q_{gs}		-	2.1	-	
Gate - Drain charge	Q_{gd}		-	1.1	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS}=10V, V_{DS}=15V, R_G=3.3\Omega, I_D=20A$	-	10	-	ns
Turn-ON Rise time	t_r		-	4.2	-	ns
Turn-Off Delay time	$t_{D(off)}$		-	15	-	ns
Turn-Off Fall time	t_f		-	4.4	-	ns
Reverse Recovery Time	t_{RR}	$V_{DD}=20V, dI_S/dt=100A/\mu s, I_S=20A$	-	57	-	ns
Reverse Recovery Charge	Q_{RR}		-	80	-	nC

Fig.1 Gate-Charge Characteristics

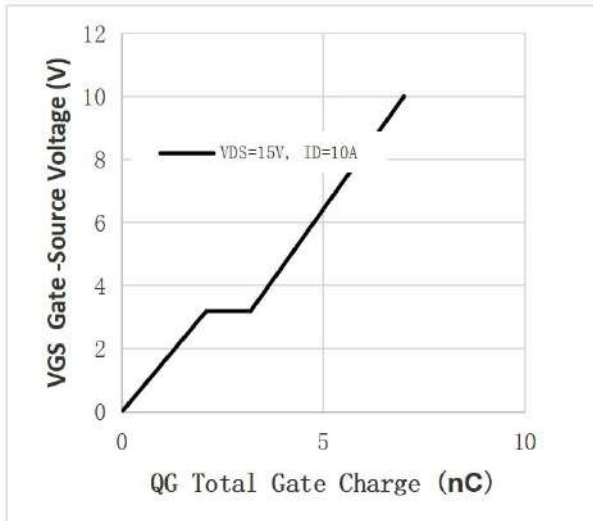


Fig.2 Capacitance Characteristics

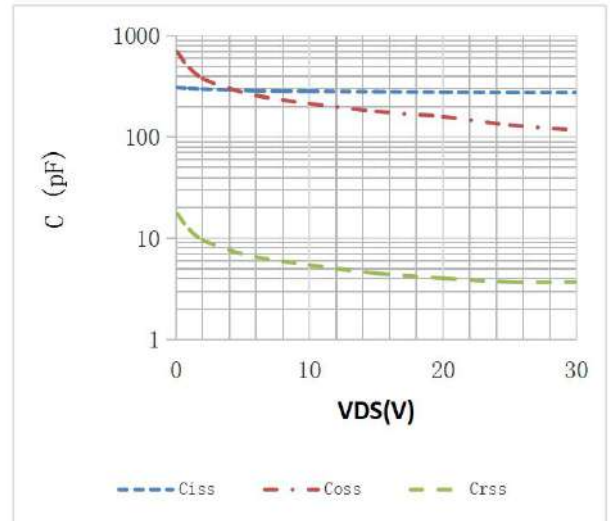


Fig.3 Power Dissipation

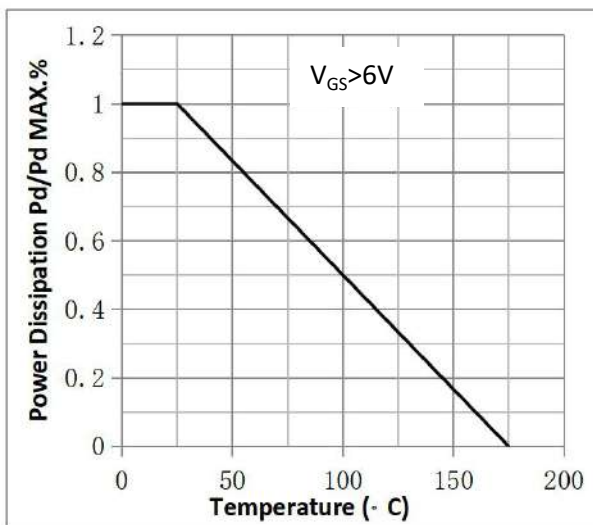


Fig.4 Typical output Characteristics

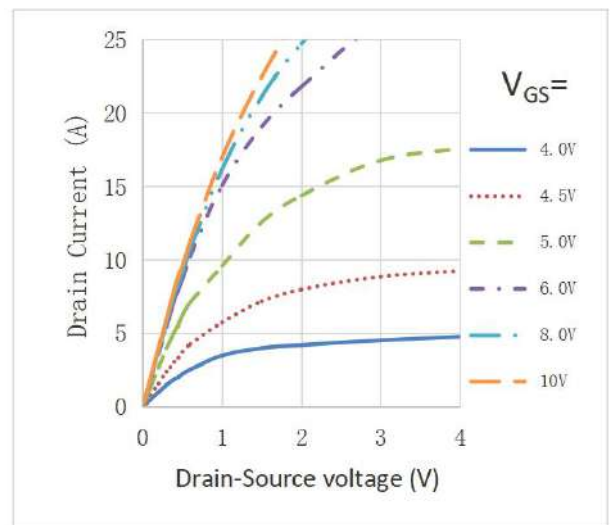


Fig.5 Threshold Voltage V.S Junction Temperature

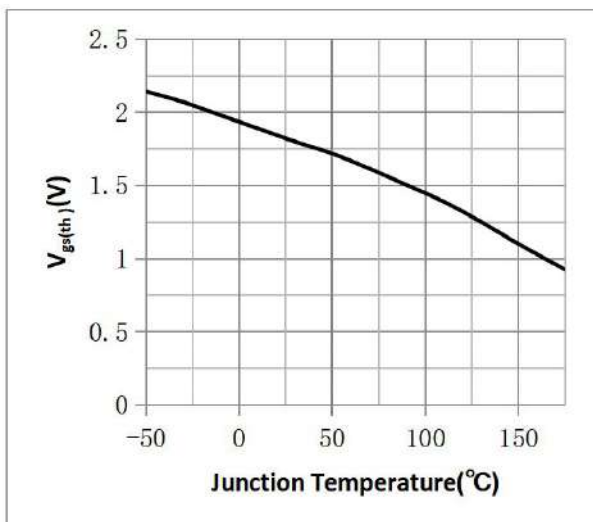


Fig.6 Resistance V.S Drain Current

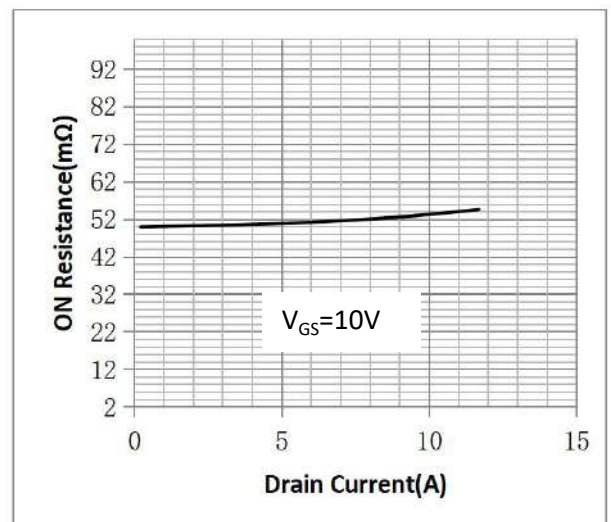


Fig.7 On-Resistance VS Gate Source Voltage

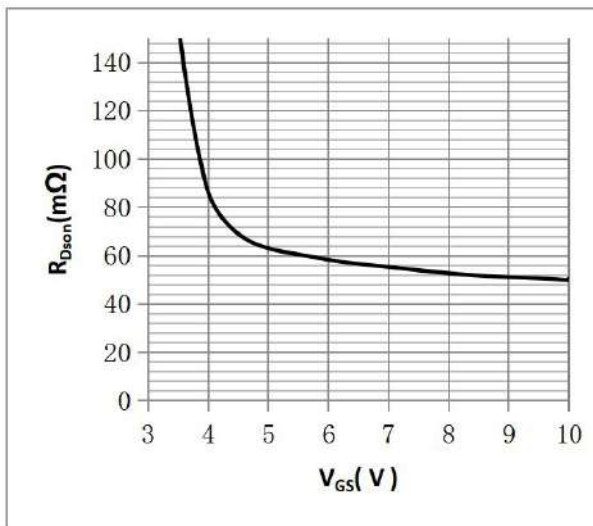


Fig.8 On-Resistance V.S Junction Temperature

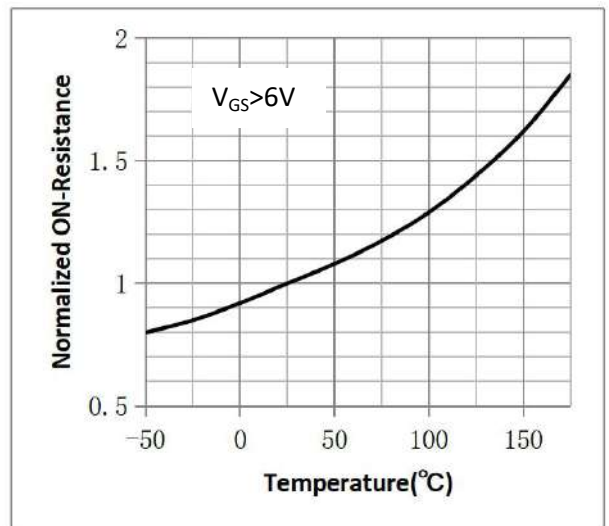


Figure 9. Diode Forward Voltage vs. Current

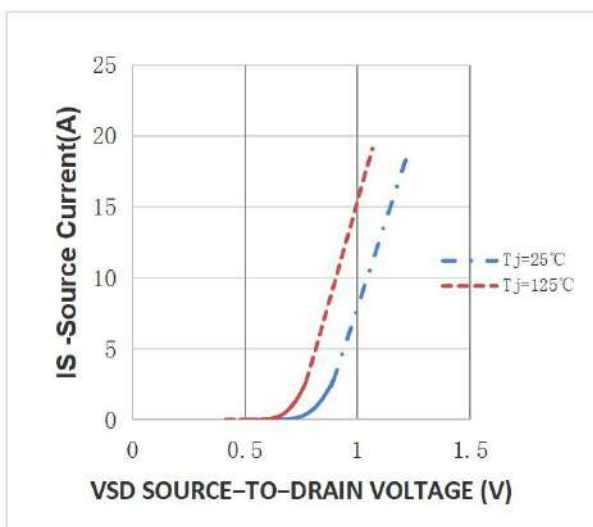


Figure 10. Transfer Characteristics

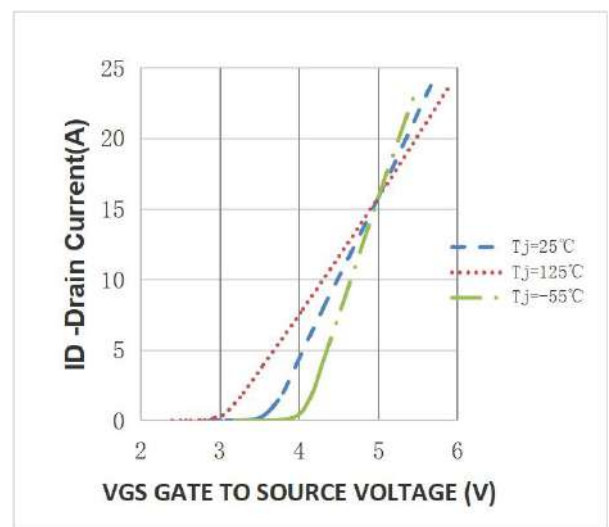


Fig.11 Safe Operating Area

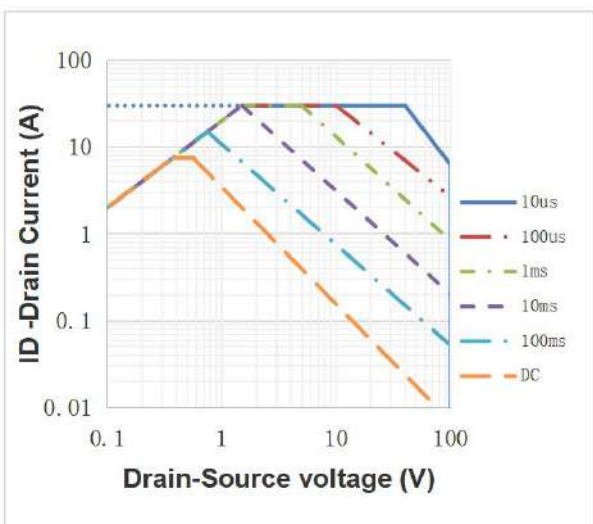
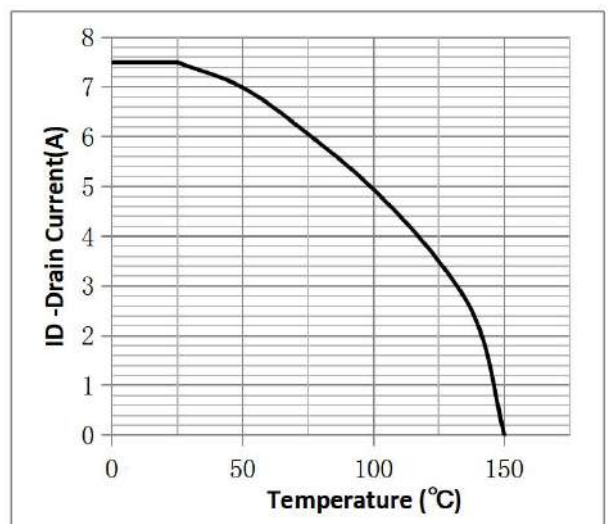
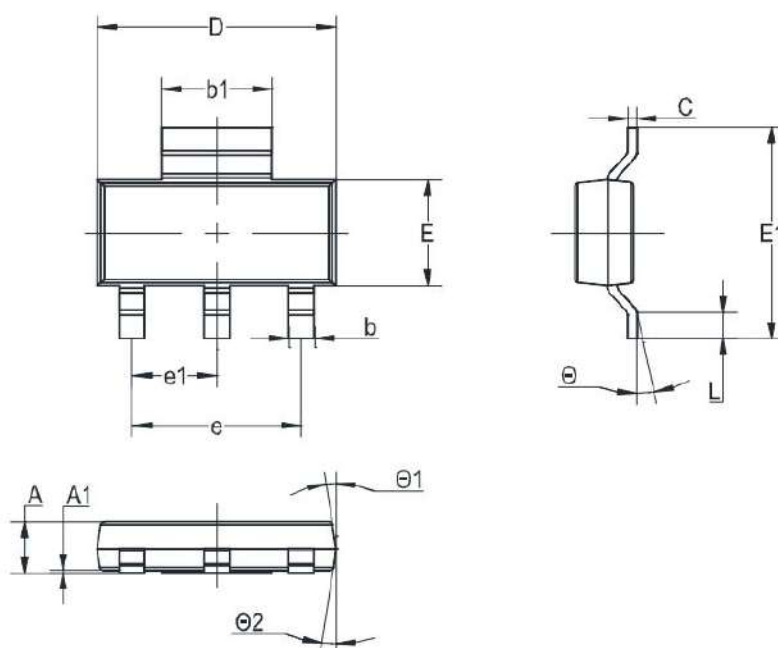


Fig.12 ID vs. Case Temperature^③

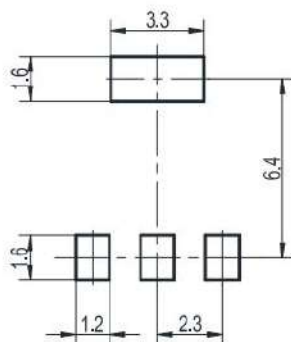


●SOT-223 Package Outline



Unit	A	A1	b	b1	C	D	E	E1	e	e1	L	Θ	Θ1	Θ2
mm	1.8 1.5	0.1 MAX	0.8 0.6	3.1 2.9	0.32 0.22	6.7 6.3	3.7 3.3	7.3 6.7	4.6 TYP	2.3 TYP	1.1 0.7	10° 0°	7° 0°	7° 0°

Recommended Soldering Footprint



Packing information

Package	Tape Width (mm)	Pitch		Reel Size		Per Reel Packing Quantity
		mm	inch	mm	inch	
SOT-223	12	8 ± 0.1	0.315 ± 0.004	330	13	3,000